Rev. 01 — 19 April 2006

**Objective data sheet** 

### 1. Product profile

#### 1.1 General description

180 W LDMOS power transistor for base station applications at frequencies from 1800 MHz to 2000 MHz.

#### Table 1: Typical performance

RF performance at T<sub>case</sub> = 25 °C in a common source class-AB production test circuit.

Mode of operation	f		P <sub>L(AV)</sub>	Gp	η <sub>D</sub>	ACPR
	(MHz)	(V)	(W)	(dB)	(%)	(dBc)
2-carrier W-CDMA	1805 to 1880	32	50	17.5	27.5	-35 <mark>[1]</mark>

[1] Test signal: 3GPP; test model 1; 64 DPCH; PAR = 7.5 dB at 0.01 % probability on CCDF per carrier; carrier spacing 5 MHz

#### CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

#### 1.2 Features

- Typical 2-carrier W-CDMA performance at frequencies of 1805 MHz and 1880 MHz, a supply voltage of 32 V and an I<sub>Dq</sub> of 1600 mA:
  - Average output power = 50 W
  - Power gain = 17.5 dB (typ)
  - Efficiency = 27.5 %
  - ♦ ACPR = -35 dBc
- Easy power control
- Integrated ESD protection
- Excellent ruggedness
- High efficiency
- Excellent thermal stability
- Designed for broadband operation (1800 MHz to 2000 MHz)
- Internally matched for ease of use

#### **1.3 Applications**

RF power amplifiers for W-CDMA base stations and multi carrier applications in the 1800 MHz to 2000 MHz frequency range.



**UHF power LDMOS transistor** 

# 2. Pinning information

Table 2:	Pinning	
Pin	Description	Simplified outline Symbol
1	drain1	<tbd></tbd>
2	drain2	
3	gate1	
4	gate2	3 4
5	source	[1]
[1] Conne	ected to flange	

# 3. Ordering information

Table 3: Order	ing inform	nation	
Type number	Packag	e	
	Name	Description	Version
BLF6G20-180P	-	flanged balanced LDMOST ceramic package; 2 mounting holes; 4 leads	SOT539A

# 4. Limiting values

#### Table 4: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>DS</sub>	drain-source voltage		-	65	V
$V_{GS}$	gate-source voltage		-0.5	+13	V
I <sub>D</sub>	drain current		-	<tbd></tbd>	А
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature		-	225	°C

### 5. Thermal characteristics

Table 5:	Thermal characteristics			
Symbol	Parameter	Conditions	Тур	Unit
$R_{th(j-case)}$	thermal resistance from junction to case	T <sub>case</sub> = 80 °C; P <sub>L(AV)</sub> = 50 W	0.45	K/W

### 6. Characteristics

#### Table 6: Characteristics

 $T_i = 25 \circ C$  per section; unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	$V_{GS}$ = 0 V; I <sub>D</sub> = 0.5 mA	65	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	$V_{DS}$ = 10 V; $I_{D}$ = 144 mA	<tbd></tbd>	1.6	<tbd></tbd>	V
$V_{GSq}$	gate-source quiescent voltage	$V_{DS} = 28 \text{ V}; I_D = 950 \text{ mA}$	<tbd></tbd>	2	<tbd></tbd>	V
I <sub>DSS</sub>	drain leakage current	$V_{GS} = 0 \text{ V};  V_{DS} = 28 \text{ V}$	-	-	5	μΑ
I <sub>DSX</sub>	drain cut-off current	$\label{eq:VGS} \begin{array}{l} V_{GS} = V_{GS(th)} + 3.75 \; V; \\ V_{DS} = 10 \; V \end{array}$	-	26	-	A
I <sub>GSS</sub>	gate leakage current	$V_{GS}$ = 8.5 V; $V_{DS}$ = 0 V	-	-	450	nA
g <sub>fs</sub>	forward transconductance	$V_{DS}$ = 10 V; $I_{D}$ = 7.2 A	-	13	-	S
R <sub>DS(on)</sub>	drain-source on-state resistance	$\label{eq:VGS} \begin{array}{l} V_{\text{GS}} = V_{\text{GS(th)}} + 3.75 \; V; \\ I_{\text{D}} = 5 \; A \end{array}$	-	0.1	<tbd></tbd>	Ω
C <sub>rs</sub>	feedback capacitance	$V_{GS} = 0 V; V_{DS} = 28 V;$ f = 1 MHz	-	<tbd></tbd>	-	pF

## 7. Application information

#### Table 7: Application information

Mode of operation: 2-carrier W-CDMA; PAR 7.5 dB at 0.01 % probability on CCDF; 3GPP test model 1; 1 to 64 PDPCH;  $f_1 = 1802.5$  MHz;  $f_2 = 1807.5$  MHz;  $f_3 = 1872.5$  MHz;  $f_4 = 1877.5$  MHz; RF performance at  $V_{DS} = 32$  V;  $I_{Dq} = 1600$  mA;  $T_{case} = 25$  °C; unless otherwise specified; in a class-AB production test circuit

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
P <sub>L(AV)</sub>	average output power		-	50	-	W
G <sub>p</sub>	power gain	$P_{L(AV)} = 50 \text{ W}$	<tbd></tbd>	17.5	-	dB
$\eta_D$	drain efficiency	$P_{L(AV)} = 50 \text{ W}$	<tbd></tbd>	27.5	-	%
ACPR	adjacent channel power ratio	$P_{L(AV)} = 50 \text{ W}$	-	-35	<tbd></tbd>	dBc

#### 7.1 Ruggedness in class-AB operation

The BLF6G20-180P is capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions:  $V_{DS}$  = 28 V;  $I_{Dq}$  = 1600 mA;  $P_L$  = 180 W (CW); f = 1880 MHz.

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**UHF power LDMOS transistor** 

### 8. Package outline

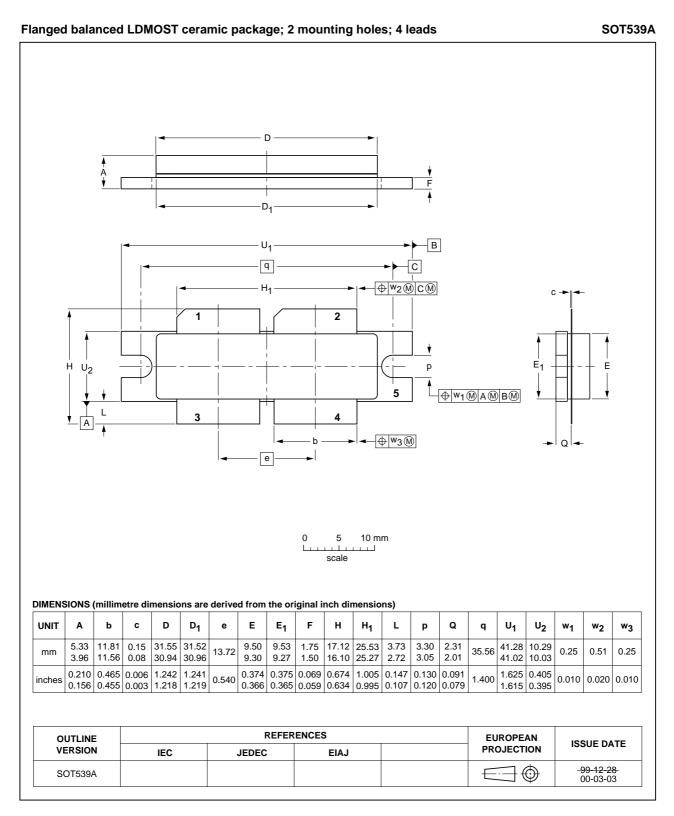


Fig 1. Package outline SOT539A BLF6G20-180P\_1 Objective data sheet

# BLF6G20-180P

UHF power LDMOS transistor

# 9. Abbreviations

Table 8:	Abbreviations
Acronym	Description
3GPP	Third Generation Partnership Project
CCDF	Complementary Cumulative Distribution Function
CW	Continuous Wave
DPCH	Dedicated Physical CHannel
LDMOS	Laterally Diffused Metal Oxide Semiconductor
PAR	Peak-to-Average power Ratio
PDPCH	transmission Power of the Dedicated Physical CHannel
RF	Radio Frequency
VSWR	Voltage Standing Wave Ratio
W-CDMA	Wideband Code Division Multiple Access



UHF power LDMOS transistor

# **10. Revision history**

Table 9: Revision histo	Revision history						
Document ID	Release date	Data sheet status	Change notice	Supersedes			
BLF6G20-180P_1	20060419	Objective data sheet	-	-			

# **11. Legal information**

#### 11.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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[2] The term 'short data sheet' is explained in section "Definitions".

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# **BLF6G20-180P**

**UHF power LDMOS transistor** 

### 13. Contents

1	Product profile 1
1.1	General description
1.2	Features 1
1.3	Applications 1
2	Pinning information 2
3	Ordering information 2
4	Limiting values 2
5	Thermal characteristics 3
6	Characteristics 3
7	Application information 3
7.1	Ruggedness in class-AB operation 3
8	Package outline 4
9	Abbreviations 5
10	Revision history 6
11	Legal information 7
11.1	Data sheet status 7
11.2	Definitions
11.3	Disclaimers
11.4	Trademarks 7
12	Contact information 7
13	Contents 8



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